

Small Outline Optoisolators

Transistor Output

These devices consist of a gallium arsenide infrared emitting diode optically coupled to a monolithic silicon phototransistor detector, in a surface mountable, small outline, plastic package. They are ideally suited for high density applications, and eliminate the need for through–the–board mounting.

- Convenient Plastic SOIC-8 Surface Mountable Package Style
- · Closely Matched Current Transfer Ratios
- Minimum V(BR)CEO of 70 Volts Guaranteed
- Standard SOIC–8 Footprint, with 0.050" Lead Spacing
- Compatible with Dual Wave, Vapor Phase and IR Reflow Soldering
- High Input-Output Isolation of 3000 Vac (rms) Guaranteed
- • UL Recognized File #E90700, Volume 2

Ordering Information:

- To obtain MOC205, 206, 207, 208 in Tape and Reel, add R2 suffix to device numbers: R2 = 2500 units on 13" reel
- To obtain MOC205, 206, 207, 208 in quantities of 50 (shipped in sleeves) No Suffix

Marking Information:

- • MOC205 = 205
- MOC206 = 206
- • MOC207 = 207
- MOC208 = 208

Applications:

• Feedback Control Circuits

Derate above 25°C

- · Interfacing and coupling systems of different potentials and impedances
- · General Purpose Switching Circuits
- Monitor and Detection Circuits

MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

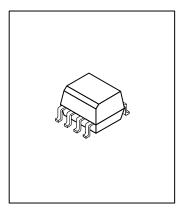
Rating	Symbol	Value	Unit	
INPUT LED				
Forward Current — Continuous	IF	60	mA	
Forward Current — Peak (PW = 100 μs, 120 pps)	I _F (pk)	1.0	А	
Reverse Voltage	VR	6.0	V	
LED Power Dissipation @ T _A = 25°C Derate above 25°C	PD	90 0.8	mW mW/°C	
OUTPUT TRANSISTOR				
Collector–Emitter Voltage	VCEO	70	V	
Collector–Base Voltage	V _{CBO}	70	V	
Emitter–Collector Voltage	VECO	7.0	V	
Collector Current — Continuous	Ic	150	mA	
Detector Power Dissipation @ T _A = 25°C	PD	150	mW	

1.76

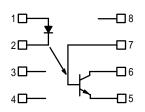
mW/°C

MOC205 MOC206 MOC207 MOC208

SMALL OUTLINE OPTOISOLATORS TRANSISTOR OUTPUT







- 1. LED ANODE
- 2. LED CATHODE
- 3. NO CONNECTION
- 4. NO CONNECTION
- 5. EMITTER
- 6. COLLECTOR
- 7. BASE
- 8. NO CONNECTION



MOC205, MOC206, MOC207, MOC208

MAXIMUM RATINGS — **continued** (T_A = 25°C unless otherwise noted)

Rating		Symbol	Va	lue	Unit
TOTAL DEVICE		•	•		
Input-Output Isolation Voltage ^(1,2) (60 Hz, 1.0 sec. duration)		VISO	30	000	Vac(rms)
Total Device Power Dissipation @ T _A = 25°C Derate above 25°C		PD		50 94	mW mW/°C
Ambient Operating Temperature Range(3)		TA	–45 to	+100	°C
Storage Temperature Range ⁽³⁾		T _{stg}	–45 to	+125	°C
Lead Soldering Temperature (1/16" from case, 10 sec. duration)	d Soldering Temperature (1/16" from case, 10 sec. duration)		2	60	°C
ELECTRICAL CHARACTERISTICS (T _A = 25°C unless otherwise	noted)(4)				
Characteristic	Symbol	Min	Тур(4)	Max	Unit
INPUT LED					
Forward Voltage (I _F = 10 mA)	٧ _F	_	1.15	1.5	V
Reverse Leakage Current (V _R = 6.0 V)	I _R	_	0.1	100	μΑ
Capacitance	С	_	18	_	pF
OUTPUT TRANSISTOR					
Collector–Emitter Dark Current (V _{CE} = 10 V, T _A = 25°C)	ICEO1	_	1.0	50	nA
$(V_{CE} = 10 \text{ V}, T_{A} = 100^{\circ}\text{C})$	I _{CEO} 2	_	1.0	_	μΑ
Collector–Emitter Breakdown Voltage (I _C = 100 μA)	V _(BR) CEO	70	120	_	V
Emitter–Collector Breakdown Voltage (I _E = 100 μA)	V(BR)ECO	7.0	7.8	_	V
Collector–Emitter Capacitance (f = 1.0 MHz, V _{CE} = 0)	C _{CE}	_	7.0	_	pF
COUPLED					
Output Collector Current MOC205 (IF = 10 mA, V _{CE} = 10 V) MOC206 MOC207 MOC208	I _C (CTR) ⁽⁵⁾	4.0 (40) 6.3 (63) 10 (100) 4.0 (40)	6.0 (60) 9.4 (94) 15 (150) 8.0 (80)	8.0 (80) 12.5 (125) 20 (200) 12.5 (125)	mA (%)
Collector–Emitter Saturation Voltage (I _C = 2.0 mA, I _F = 10 mA)	V _{CE(sat)}	_	0.15	0.4	V
Turn–On Time (I _C = 2.0 mA, V_{CC} = 10 V, R_L = 100 Ω)	ton	_	3.0	_	μs
Turn–Off Time (I _C = 2.0 mA, V_{CC} = 10 V, R_L = 100 Ω)	toff	_	2.8	_	μs
Rise Time (I _C = 2.0 mA, V_{CC} = 10 V, R_L = 100 Ω)	t _r	_	1.6	_	μs
Fall Time (I _C = 2.0 mA, V _{CC} = 10 V, R _L = 100 Ω)	t _f	_	2.2	l —	μs

3000

1011

0.2

Vac(rms)

Ω

Viso

RISO

CISO

- 1. Input–Output Isolation Voltage, $V_{\mbox{\scriptsize ISO}}$, is an internal device dielectric breakdown rating.
- 2. For this test, pins 1 and 2 are common, and pins 5, 6 and 7 are common.
- 3. Refer to Quality and Reliability Section in Opto Data Book for information on test conditions.
- 4. Always design to the specified minimum/maximum electrical limits (where applicable).
- 5. Current Transfer Ratio (CTR) = I_C/I_F x 100%.

Isolation Capacitance $(V_{I-O} = 0, f = 1.0 \text{ MHz})(2)$

Isolation Resistance $(V_{I-O} = 500 \text{ V})(2)$

Input–Output Isolation Voltage (f = 60 Hz, t = 1.0 sec.)(1,2)

MOC205, MOC206, MOC207, MOC208

TYPICAL CHARACTERISTICS

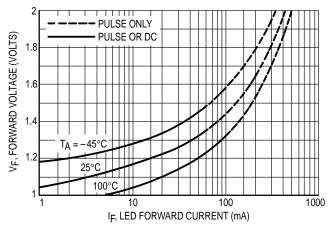


Figure 1. LED Forward Voltage versus Forward Current

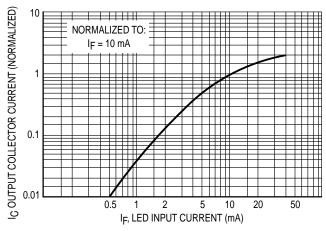


Figure 2. Output Current versus Input Current

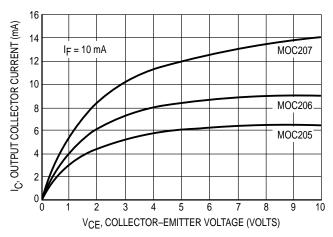


Figure 3. Output Current versus Collector–Emitter Voltage

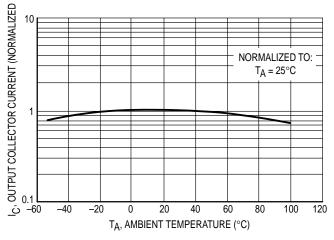


Figure 4. Output Current versus Ambient Temperature

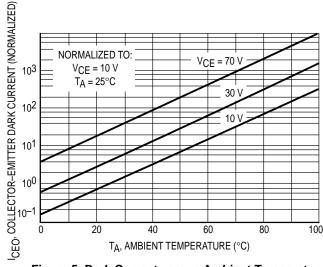


Figure 5. Dark Current versus Ambient Temperature

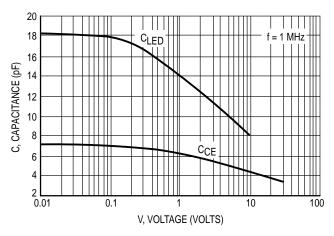
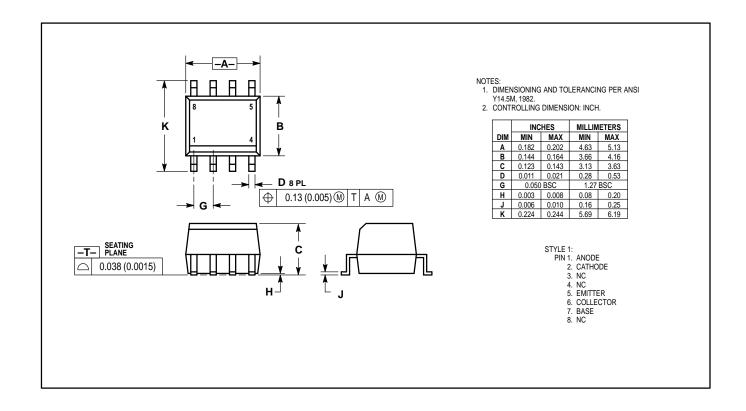


Figure 6. Capacitance versus Voltage



MOC205, MOC206, MOC207, MOC208





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